

"OMNIFET II": FULLY AUTOPROTECTED POWER MOSFET

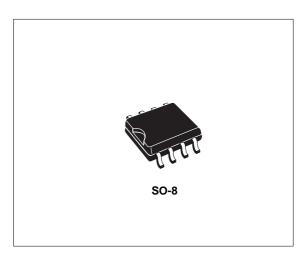
TYPE	R _{DS(on)}	I _{lim}	V _{clamp}	
VNS1NV04D	250 mΩ (*)	1.7 A (*)	40 V (*)	

(*) Per each device

- LINEAR CURRENT LIMITATION
- THERMAL SHUT DOWN
- SHORT CIRCUIT PROTECTION
- INTEGRATED CLAMP
- LOW CURRENT DRAWN FROM INPUT PIN
- DIAGNOSTIC FEEDBACK THROUGH INPUT PIN
- ESD PROTECTION
- DIRECT ACCESS TO THE GATE OF THE POWER MOSFET (ANALOG DRIVING)
- COMPATIBLE WITH STANDARD POWER MOSFET



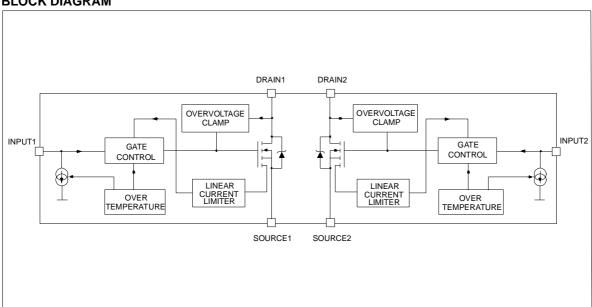
The VNS1NV04D is a device formed by two monolithic OMNIFET II chips housed in a standard SO-8 package. The OMNIFET II are designed in STMicroelectronics VIPower M0-3



Technology: they are intended for replacement of standard Power MOSFETS from DC up to 50KHz applications. Built in thermal shutdown, linear current limitation and overvoltage clamp protects the chip in harsh environments.

Fault feedback can be detected by monitoring the voltage at the input pin.

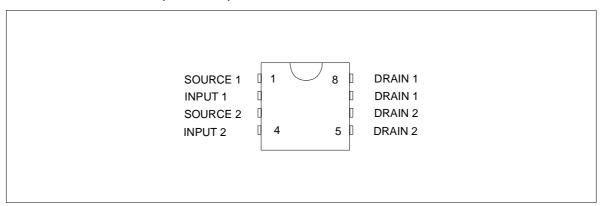
BLOCK DIAGRAM



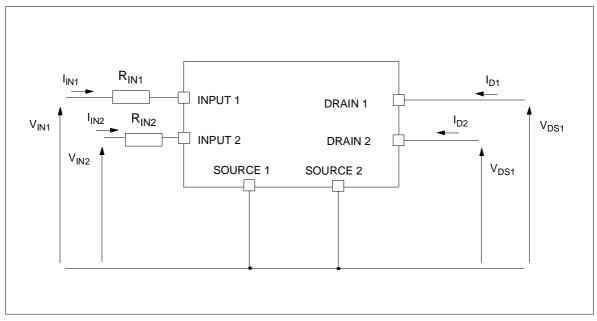
ABSOLUTE MAXIMUM RATING

Symbol	Parameter	Value	Unit
V _{DSn}	Drain-source Voltage (V _{INn} =0V)	Internally Clamped	V
V _{INn}	Input Voltage	Internally Clamped	V
I _{INn}	Input Current	+/-20	mA
R _{IN MINn}	Minimum Input Series Impedance	330	Ω
I _{Dn}	Drain Current	Internally Limited	Α
I _{Rn}	Reverse DC Output Current	-3	Α
V _{ESD1}	Electrostatic Discharge (R=1.5KΩ, C=100pF)	4000	V
V _{ESD2}	Electrostatic Discharge on output pins only (R=330Ω, C=150pF)	16500	V
P _{tot}	Total Dissipation at T _c =25°C	4	W
Tj	Operating Junction Temperature	Internally limited	°C
T _c	Case Operating Temperature	Internally limited	°C
T _{stg}	Storage Temperature	-55 to 150	°C

CONNECTION DIAGRAM (TOP VIEW)



CURRENT AND VOLTAGE CONVENTIONS



THERMAL DATA

Symbol	Parameter		Value	Unit
R _{thj-lead}	Thermal Resistance Junction-lead (per channel)	MAX	30	°C/W
R _{thi-amb}	Thermal Resistance Junction-ambient	MAX	80(*)	°C/W

^(*) When mounted on a standard single-sided FR4 board with 50mm^2 of Cu (at least $35 \, \mu \text{m}$ thick) connected to all DRAIN pins of the relative channel.

ELECTRICAL CHARACTERISTICS (-40°C < T_j < 150°C, unless otherwise specified) (Per each device)

OFF

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
W	Drain-source Clamp	V _{IN} =0V; I _D =0.5A	40	45	55	V
V _{CLAMP}	Voltage	V _{IN} =0V, I _D =0.5A	40	45	55	V
V _{CLTH}	Drain-source Clamp	V _{IN} =0V; I _D =2mA	36			V
*CLIH	Threshold Voltage	VIN-5 V, ID-2.117 V	0			•
V _{INTH}	Input Threshold Voltage	$V_{DS}=V_{IN}; I_{D}=1mA$	0.5		2.5	V
I _{ISS}	Supply Current from Input	V _{DS} =0V; V _{IN} =5V		100	150	μА
133	Pin	103 11, 11N 11				P** -
\/ ·	Input-Source Clamp	I _{IN} =1mA	6	6.8	8	V
V _{INCL}	Voltage	I _{IN} =-1mA	-1.0		-0.3	V
1	Zero Input Voltage Drain	V _{DS} =13V; V _{IN} =0V; T _j =25°C			30	μΑ
I _{DSS}	Current (V _{IN} =0V)	V_{DS} =25V; V_{IN} =0V			75	μΑ

ON

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
В	Static Drain-source On	$V_{IN}=5V; I_{D}=0.5A; T_{j}=25^{\circ}C$			250	mΩ
NDS(on)	Resistance	V _{IN} =5V; I _D =0.5A			500	mΩ

ELECTRICAL CHARACTERISTICS (continued) (T_j =25°C, unless otherwise specified) DYNAMIC

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
g _{fs} (*)	Forward Transconductance	V _{DD} =13V; I _D =0.5A		2		S
C _{OSS}	Output Capacitance	V _{DS} =13V; f=1MHz; V _{IN} =0V		90		рF

SWITCHING

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
t _{d(on)}	Turn-on Delay Time	V _{DD} =15V; I _D =0.5A		70	200	ns
t _r	Rise Time	$V_{\text{gen}}=5V$; $R_{\text{gen}}=R_{\text{IN MINn}}=330\Omega$		170	500	ns
t _{d(off)}	Turn-off Delay Time	ygen-5v, Ngen-NN MINn-53032 (see figure 1)		350	1000	ns
t _f	Fall Time	(see ligure 1)		200	600	ns
t _{d(on)}	Turn-on Delay Time	V _{DD} =15V; I _D =0.5A		0.25	1.0	μs
t _r	Rise Time	V_{gen} =5V; R_{gen} =2.2K Ω		1.3	4.0	μs
t _{d(off)}	Turn-off Delay Time	9		1.8	5.5	μs
t _f	Fall Time	(see figure 1)		1.2	4.0	μs
(dl/dt) _{on}	Turn-on Current Slope	V_{DD} =15V; I_{D} =1.5A V_{gen} =5V; R_{gen} = $R_{IN\ MINn}$ =330Ω		5.0		A/μs
Qi	Total Input Charge	V_{DD} =12V; I_D =0.5A; V_{IN} =5V I_{gen} =2.13mA (see figure 5)		5.0		nC

SOURCE DRAIN DIODE

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
V _{SD} (*)	Forward On Voltage	I _{SD} =0.5A; V _{IN} =0V		0.8		V
t _{rr}	Reverse Recovery Time	I _{SD} =0.5A; dI/dt=6A/μs		205		ns
Q _{rr}	Reverse Recovery Charge	V _{DD} =30V; L=200μH		100		μC
I _{RRM}	Reverse Recovery Current	(see test circuit, figure 2)		0.75		Α

PROTECTIONS (-40°C < T_{j} < 150°C, unless otherwise specified)

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
I _{lim}	Drain Current Limit	V _{IN} =5V; V _{DS} =13V	1.7		3.5	Α
t _{dlim}	Step Response Current Limit	V _{IN} =5V; V _{DS} =13V		2.0		μs
T _{jsh}	Overtemperature Shutdown		150	175	200	°C
T _{jrs}	Overtemperature Reset		135			°C
I _{gf}	Fault Sink Current	$V_{IN}=5V; V_{DS}=13V; T_j=T_{jsh}$	10	15	20	mA
E _{as}	Single Pulse Avalanche Energy	starting T _j =25°C; V_{DD} =24V V_{IN} =5V R_{gen} = $R_{IN\ MINn}$ =330 Ω ; L=50mH (see figures 3 & 4)	55			mJ

(*) Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%

PROTECTION FEATURES

During normal operation, the INPUT pin is electrically connected to the gate of the internal power MOSFET through a low impedance path.

The device then behaves like a standard power MOSFET and can be used as a switch from DC to 50KHz. The only difference from the user's standpoint is that a small DC current $I_{\rm ISS}$ (typ. $100\mu A$) flows into the INPUT pin in order to supply the internal circuitry.

The device integrates:

- OVERVOLTAGE CLAMP PROTECTION: internally set at 45V, along with the rugged avalanche characteristics of the Power MOSFET stage give this device unrivalled ruggedness and energy handling capability. This feature is mainly important when driving inductive loads.
- LINEAR CURRENT LIMITER CIRCUIT: limits the drain current I_D to I_{lim} whatever the INPUT pin voltage. When the current limiter is active, the device operates in the linear region, so power dissipation may exceed the capability of the heatsink. Both case and junction temperatures increase, and if this phase lasts long enough, junction temperature may reach the overtemperature threshold T_{ish} .

- OVERTEMPERATURE AND SHORT CIRCUIT PROTECTION: these are based on sensing the chip temperature and are not dependent on the input voltage. The location of the sensing element on the chip in the power stage area ensures fast, accurate detection of the junction temperature. Overtemperature cutout occurs in the range 150 to 190 °C, a typical value being 170 °C. The device is automatically restarted when the chip temperature falls of about 15°C below shut-down temperature.
- STATUS FEEDBACK: in the case of an overtemperature fault condition $(T_j > T_{jsh}),$ the device tries to sink a diagnostic current I_{gf} through the INPUT pin in order to indicate fault condition. If driven from a low impedance source, this current may be used in order to warn the control circuit of a device shutdown. If the drive impedance is high enough so that the INPUT pin driver is not able to supply the current I_{gf} , the INPUT pin will fall to 0V. This will not however affect the device operation: no requirement is put on the current capability of the INPUT pin driver except to be able to supply the normal operation drive current I_{ISS} .

Additional features of this device are ESD protection according to the Human Body model and the ability to be driven from a TTL Logic circuit.

Figure 1: Switching Time Test Circuit for Resistive Load

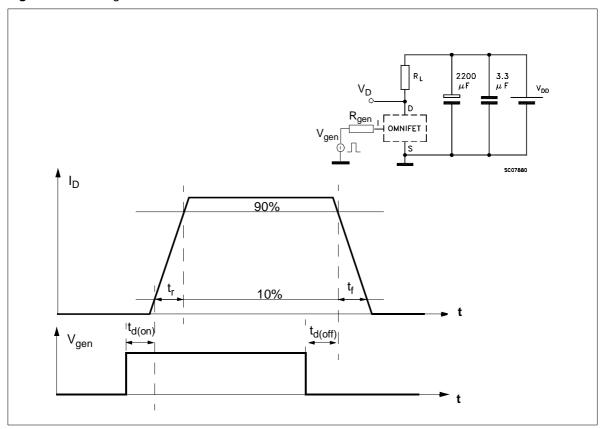


Figure 2: Test Circuit for Diode Recovery Times

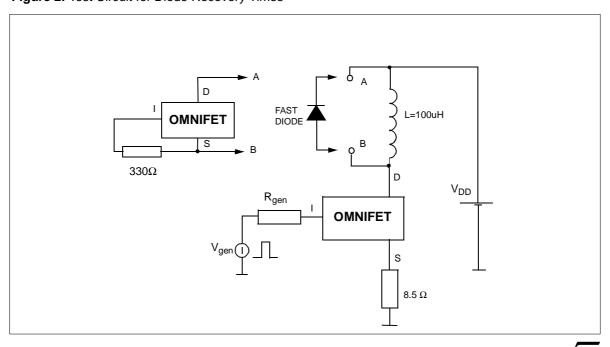


Figure 3: Unclamped Inductive Load Test Circuits

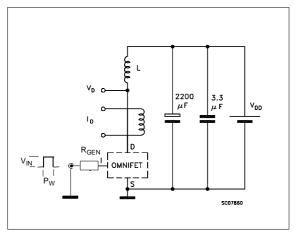


Figure 4: Unclamped Inductive Waveforms

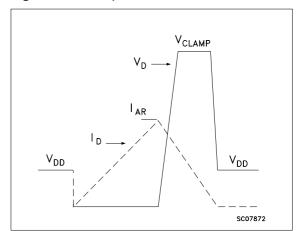
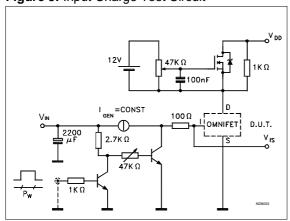
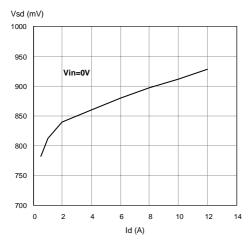


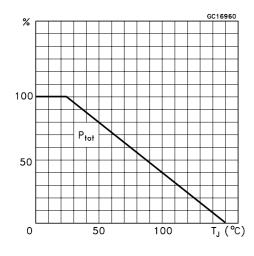
Figure 5: Input Charge Test Circuit



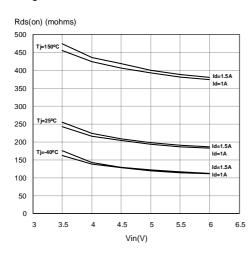
Source-Drain Diode Forward Characteristics



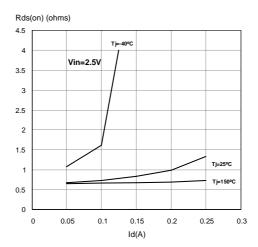
Derating Curve



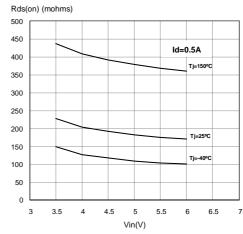
Static Drain-Source On resistance Vs. Input Voltage



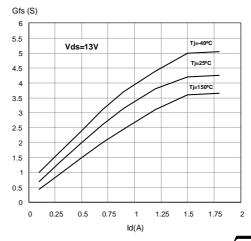
Static Drain Source On Resistance



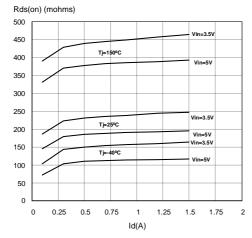
Static Drain-Source On resistance Vs. Input Voltage



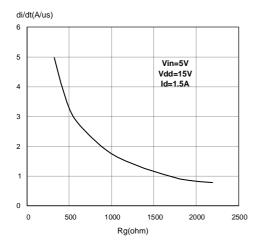
Transconductance



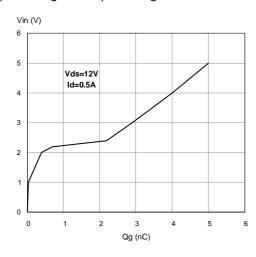
Static Drain-Source On Resistance Vs. Id



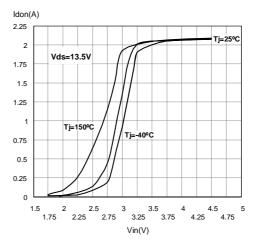
Turn On Current Slope



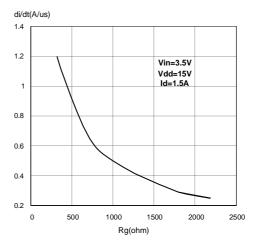
Input Voltage Vs. Input Charge



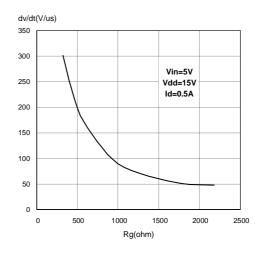
Transfer Characteristics



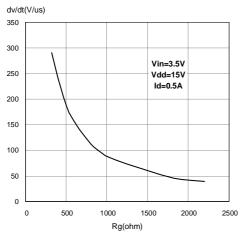
Turn On Current Slope



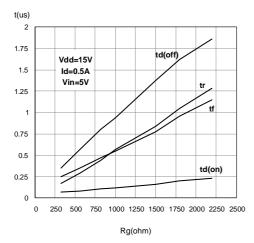
Turn off drain source voltage slope



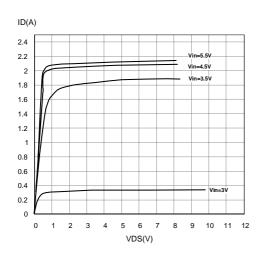
Turn Off Drain-Source Voltage Slope



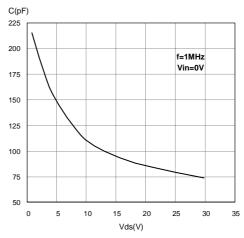
Switching Time Resistive Load



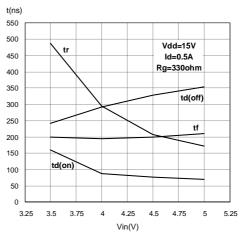
Output Characteristics



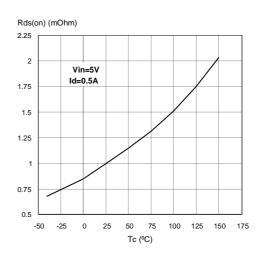
Capacitance Variations



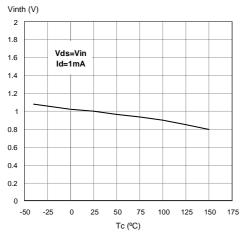
Switching Time Resistive Load



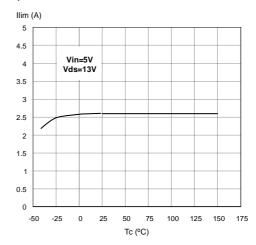
Normalized On Resistance Vs. Temperature



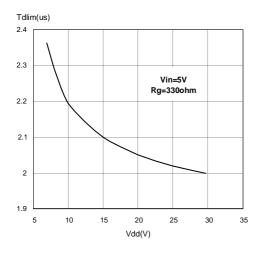
Normalized Input Threshold Voltage Vs. Temperature



Normalized Current Limit Vs. Junction Temperature

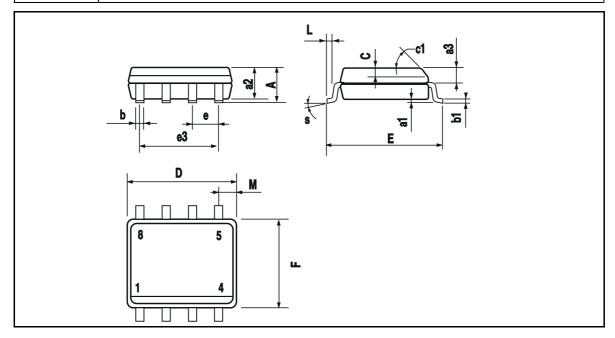


Step Response Current Limit

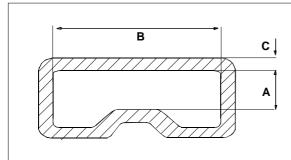


SO-8 MECHANICAL DATA

DIM		mm.			inch	
DIM.	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
Α			1.75			0.068
a1	0.1		0.25	0.003		0.009
a2			1.65			0.064
а3	0.65		0.85	0.025		0.033
b	0.35		0.48	0.013		0.018
b1	0.19		0.25	0.007		0.010
С	0.25		0.5	0.010		0.019
c1			45	(typ.)		•
D	4.8		5.0	0.188		0.196
Е	5.8		6.2	0.228		0.244
е		1.27			0.050	
e3		3.81			0.150	
F	3.8		4.0	0.14		0.157
L	0.4		1.27	0.015		0.050
M			0.6			0.023
F			8 (r	nax.)		I.



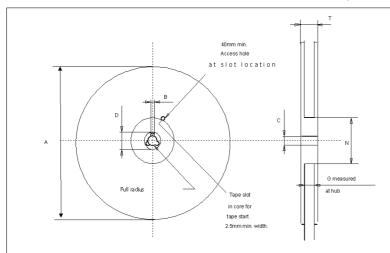
SO-8 TUBE SHIPMENT (no suffix)



Base Q.ty	100
Bulk Q.ty	2000
Tube length (± 0.5)	532
Α	3.2
В	6
C (± 0.1)	0.6

All dimensions are in mm.

TAPE AND REEL SHIPMENT (suffix "13TR")



REEL DIMENSIONS

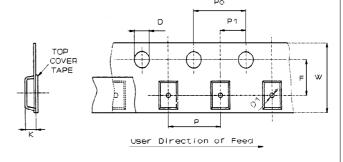
Base Q.ty	2500
Bulk Q.ty	2500
A (max)	330
B (min)	1.5
C (± 0.2)	13
F	20.2
G (+ 2 / -0)	12.4
N (min)	60
T (max)	18.4

All dimensions are in mm.

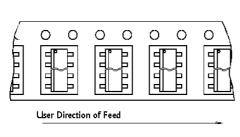
TAPE DIMENSIONS

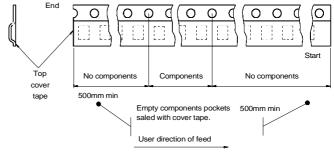
According to Electronic Industries Association (EIA) Standard 481 rev. A, Feb 1986

Tape width	w	12
Tape Hole Spacing	P0 (± 0.1)	4
Component Spacing	Р	8
Hole Diameter	D (± 0.1/-0)	1.5
Hole Diameter	D1 (min)	1.5
Hole Position	F (± 0.05)	5.5
Compartment Depth	K (max)	4.5
Hole Spacing	P1 (± 0.1)	2



All dimensions are in mm.





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